

FAN4174 / FAN4274 Single and Dual, Ultra-Low Cost, Rail-to-Rail I/O, CMOS Amplifier

Features

- 200µA Supply Current per Amplifier
- 3.7MHz Bandwidth

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- Output Swing to Within 10mV of Either Rail
- Input Voltage Range Exceeds the Rails
- 3V/µs Slew Rate
- 25nV/√Hz Input Voltage Noise
- Replaces KM4170 and KM4270
- FAN4174 Competes with OPA340 and TLV2461; Available in SC70-5 and SOT23-5 Packages
- FAN4274 Competes with OPA2340 and TLV2462; Available in MSOP-8 Package
- Fully Specified at +2.7V and +5V Supplies

Applications

- Portable / Battery-powered Applications
- PCMCIA, USB
- Mobile Communications, Cellular Phones, Pagers
- Notebooks and PDAs
- Sensor Interface
- A/D Buffer
- Active Filters
- Signal Conditioning
- Portable Test Instruments

Ordering Information

Description The FAN4174 (sir

The FAN4174 (single) and FAN4274 (dual) are ultra-low cost voltage feedback amplifiers with CMOS inputs that consume only 200μ A of supply current per amplifier, while providing ±33mA of output short-circuit current. These amplifiers are designed to operate from 2.5V to 5V supplies. The common mode voltage range extends beyond the negative and positive rails.

The FAN4174 and FAN4274 are designed on a CMOS process and provide 3.7MHz of bandwidth and 3V/µs of slew rate at a supply voltage of 5V. The combination of low power, rail-to-rail performance, low-voltage operation, and tiny package options make this amplifier family well suited for use in many general-purpose and battery-powered applications.

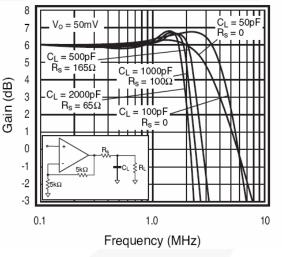
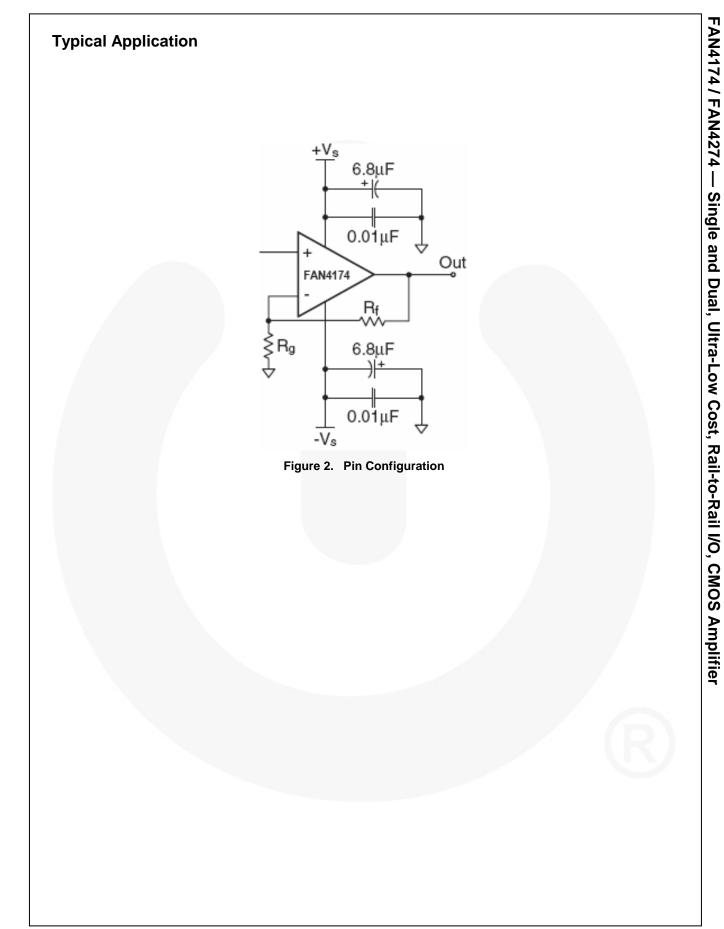


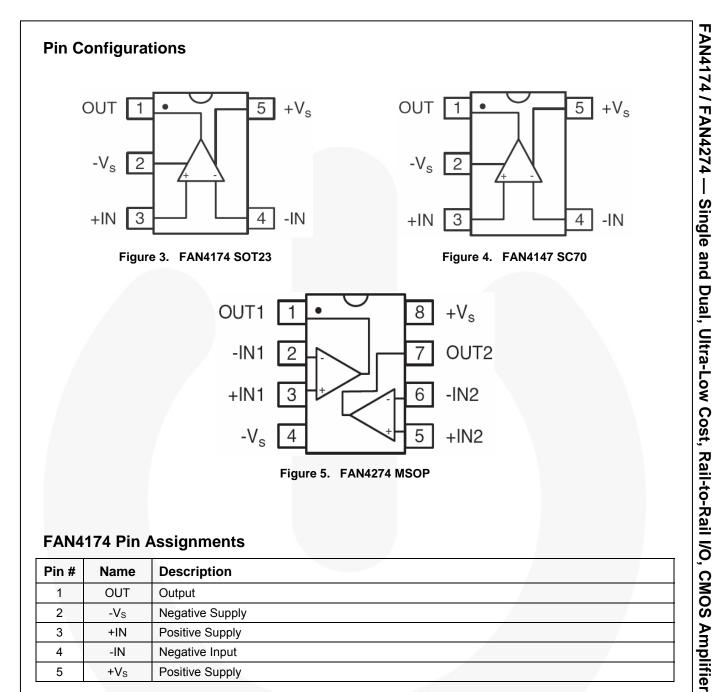
Figure 1. Frequency vs. Gain

Part Number	Operating Temperature Range	Package	Eco Status	Packing Method
FAN4174IP5X	-40 to +85°C	5-Lead SC70 Package	RoHS	Tape and Reel (3000)
FAN4174IS5X	-40 to +85°C	5-Lead SOT23 Package	RoHS	Tape and Reel (3000)
FAN4274IMU8X	-40 to +85°C	8-Lead Molded Small Outline Package	RoHS	Tape and Reel (3000)

🧶 For Fairchild's definition of "green" Eco Status, please visit: <u>http://www.fairchildsemi.com/company/green/rohs_green.html</u>.

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FAN4174 Pin Assignments

Pin #	Name	Description
1	OUT	Output
2	-Vs	Negative Supply
3	+IN	Positive Supply
4	-IN	Negative Input
5	+Vs	Positive Supply

FAN4274 Pin Assignments

Pin #	Name	Description
1	OUT1	Output, Channel 1
2	-IN1	Negative Input, Channel 1
3	+IN1	Positive Input, Channel 1
4	-Vs	Negative Supply
5	+IN2	Positive Input, Channel 2
6	-IN2	Negative Input, Channel 2
7	OUT2	Output, Channel 2
8	+Vs	Positive Supply

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Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. Functional operation under any of these conditions is NOT implied. Performance and reliability are guaranteed only if operating conditions are not exceeded.

Symbol	Paramo	eter	Min.	Max.	Unit
Vcc	Supply Voltage		0	6	V
V _{IN}	Input Voltage Range		-V _S -0.5	+V _S +0.5	V
TJ	Junction Temperature			+150	°C
T _{STG}	Storage Temperature		-65	+150	°C
TL	Lead Soldering, 10 Sec	conds		+300	°C
		5-Lead SOT23		256	
Θ_{JA}	Thermal Resistance ⁽¹⁾	5-Lead SC70		331	°C/W
		8-Lead MSOP		206	

Note:

1. Package thermal resistance JEDEC standard, multi-layer test boards, still air.

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

Symbol	Parameter	Min.	Тур.	Max.	Unit
T _A	Operating Temperature Range	-40		+85	°C

Electrical Specifications at +2.7V

 $V_{S}\text{=+2.7V},$ G=2, $R_{L}\text{=}10k\Omega$ to $V_{S}/2,$ $R_{F}\text{=}5k\Omega;$ unless otherwise noted.

Symbol	Parame	Parameter		Min.	Тур.	Max.	Units
Frequency Do	omain Response						
UGBW			G=+1		4		MHz
BW _{SS}	3dB Bandwidth				2.5		MHz
GBWP	Gain Bandwidth Pro	duct			4		MHz
Time Domain	Response				•		•
t _R , f _F	Rise and Fall Time		V ₀ =1.0V Step		300		ns
OS	Overshoot		V _O =1.0V Step		5		%
SR	Slew Rate		V _O =3V Step, G=-1		3		V/µs
Distortion and	d Noise Response						-
HD2	2nd Harmonic Disto	rtion	V _O =1V _{PP} , 10kHz		-66		dBc
HD3	3rd Harmonic Distor	rtion	V _O =1V _{PP} , 10kHz		-67		dBc
THD	Total Harmonic Dist	ortion	V _O =1V _{PP} , 10kHz		0.1		%
en	Input Voltage Noise				26		nV/√Hz
X _{TALK}	Crosstalk (FAN4274)		100kHZ		-100		dB
DC Performa	nce						
V _{IO}	Input Offset Voltage	(2)		-6	0	+6	mV
dV _{IO}	Average Drift				2.1		µV/°C
I _{bn}	Input Bias Current				5		pА
PSRR	Power Supply Rejection Ratio ⁽²⁾		DC	50	73		dB
A _{OL}	Open-loop Gain		DC		98		dB
I _S	Supply Current per Amplifier ⁽²⁾				200	300	μA
Input Charact	eristics						
R _{IN}	Input Resistance				10		GΩ
CIN	Input Capacitance				1.4		pF
CMIR	Input Common Mod	e Voltage	FAN4174 (Typical)		-0.3 to 2.6		v
CMIR	Range	-	FAN4274 (Typical)		-0.3 to 3.0		
CMRR	Common Mode	FAN4174	DC, V _{CM} =OV to 2.2V	50	65	1	dB
CIVIER	Rejection Ratio ⁽²⁾	FAN4274	DC, V _{CM} =OV to 2.2V	50	65		uв
Output Chara	cteristics						
Vo	Output Voltage Swi	ag ⁽²⁾	R _L =10k Ω to V _S /2	0.03	0.01 to 2.69	2.65	v
۷O	Output voltage Swi	'9 	$R_L \text{=} 1 \text{k} \Omega$ to $V_S \text{/} 2$		0.05 to 2.55		v
I _{SC}	Short Circuit Output	Current			+34/-12		mA
Vs	Power Supply Oper	ating Range			2.5 to 5.5		V

Note:

2. 100% tested at 25°C.

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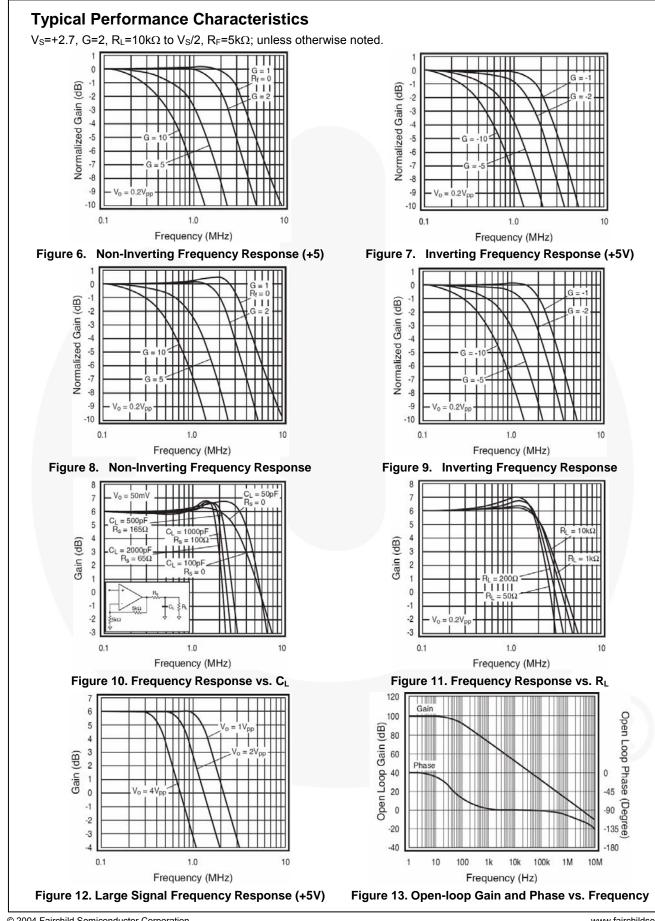
Electrical Specifications at +5V

 $V_{S}\text{=+5V},$ G=2, $R_{L}\text{=}10k\Omega$ to $V_{S}/2,$ $R_{F}\text{=}$ 5k\Omega; unless otherwise noted.

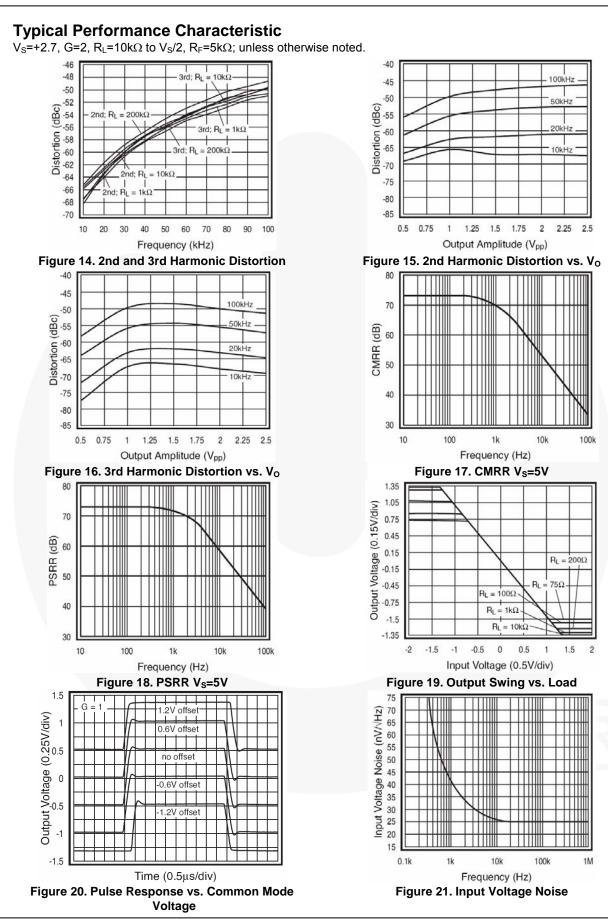
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
Frequency Do	omain Response			1		
UGBW		G=+1		3.7		MHz
BW _{SS}	3dB Bandwidth			2.3		MHz
GBWP	Gain Bandwidth Product			3.7		MHz
Time Domain	Response		•	1		•
t _R , f _F	Rise and Fall Time	V _O =1.0V Step		300		ns
OS	Overshoot	V _O =1.0V Step		5		%
SR	Slew Rate	Vo=3V Step, G=-1		3		V/µs
Distortion and	d Noise Response					
HD2	2nd Harmonic Distortion	V _O =1V _{PP} , 10kHz		-80		dBc
HD3	3rd Harmonic Distortion	V _O =1V _{PP} , 10kHz		-80		dBc
THD	Total Harmonic Distortion	V _O =1V _{PP} , 10kHz		0.02		%
en	Input Voltage Noise			25		nV/√Hz
X _{TALK}	Crosstalk (FAN4274)	100kHZ		-100		dB
DC Performar	nce					
VIO	Input Offset Voltage ⁽³⁾		-8	0	+8	mV
dV _{IO}	Average Drift			2.9		µV/°C
I _{bn}	Input Bias Current			5		pА
PSRR	Power Supply Rejection Ratio ⁽³⁾	DC	50	73		dB
A _{OL}	Open-loop Gain	DC		102		dB
Is	Supply Current per Amplifier ⁽³⁾			200	300	μA
Input Charact	eristics					
R _{IN}	Input Resistance			10		GΩ
CIN	Input Capacitance			1.2		pF
CMIR	Input Common Mode Voltage Range	Typical		-0.3 to 5.3		V
CMRR	Common Mode Rejection Ratio ⁽³⁾	DC, V_{CM} =0V to V_S	58	73		dB
Output Chara	cteristics					
N ₂	Output Voltage Swing ⁽³⁾	R _L =10k Ω to V _S /2	0.03	0.01 to 4.99	4.95	v
Vo	Calput voltage Swilly	R_L =1k Ω to $V_S/2$		0.1 to 4.9		V
I _{SC}	Short Circuit Output Current			±33		mA
Vs	Power Supply Operating Range			2.5 to 5.5		v

Note:

3. 100% tested at 25°C.



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Application Information

General Description

The FAN4174 amplifier includes single-supply, generalpurpose, voltage-feedback amplifiers, fabricated on a bi-CMOS process. The family features a rail-to-rail input and output and is unity gain stable. The typical noninverting circuit schematic is shown in Figure 22.

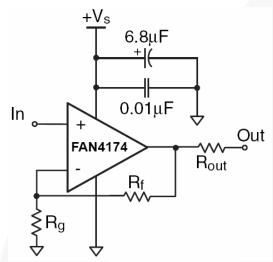


Figure 22. Typical Non-inverting Configuration

Input Common Mode Voltage

The common mode input range extends to 300mV below ground and to 100mV above V_S in single supply operation. Exceeding these values does not cause phase reversal; however, if the input voltage exceeds the rails by more than 0.5V, the input ESD devices begin to conduct. The output stays at the rail during this overdrive condition. If the absolute maximum input VIN (700mV beyond either rail) is exceeded, externally limit the input current to ±5mA, as shown in Figure 23.

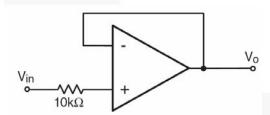


Figure 23. Circuit for Input Current Protection

Power Dissipation

The maximum internal power dissipation allowed is directly related to the maximum junction temperature. If the maximum junction temperature exceeds 150°C, performance degradation occurs. If the maximum junction temperature exceeds 150°C for an extended time, device failure may occur.

Overdrive Recovery

Overdrive of an amplifier occurs when the output and/or input ranges are exceeded. The recovery time varies based on whether the input or output is overdriven and by how much the range is exceeded. The FAN4174 typically recovers in less than 500ns from an overdrive condition. Figure 24 shows the FAN4174 amplifier in an overdriven condition.

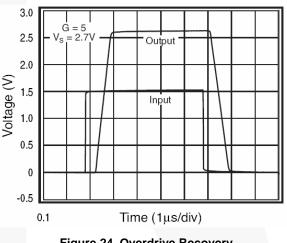
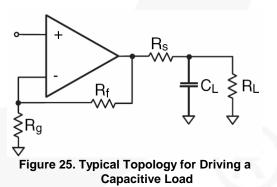


Figure 24. Overdrive Recovery

Driving Capacitive Loads

Figure 10 illustrates the response of the FAN4174 amplifier family. A small series resistance (Rs) at the output of the amplifier, illustrated in Figure 25, improves stability and settling performance. Rs values in Figure 10 were chosen to achieve maximum bandwidth with less than 2dB of peaking. For maximum flatness, use a larger Rs. Capacitive loads larger than 500pF require the use of R_S.



Driving a capacitive load introduces phase-lag into the output signal, which reduces phase margin in the amplifier. The unity gain follower is the most sensitive configuration. In a unity gain follower configuration, the FAN4174 amplifier family requires a 300Ω series resistor to drive a 100pF load.

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Layout Considerations

General layout and supply bypassing play major roles in high-frequency performance. Fairchild evaluation boards help guide high-frequency layout and aid in device testing and characterization. Follow the steps below as a basis for high-frequency layout:

- 1. Include 6.8µF and 0.01µF ceramic capacitors.
- 2. Place the 6.8μ F capacitor within 0.75 inches of the power pin.
- 3. Place the 0.01µF capacitor within 0.1 inches of the power pin.
- 4. Remove the ground plane under and around the part, especially near the input and output pins, to reduce parasitic capacitance.

Minimize all trace lengths to reduce series inductances.

Refer to the evaluation board layouts shown in Figures 28-31 for more information.

When evaluating only one channel, complete the following on the unused channel:

- 1. Ground the non-inverting input.
- 2. Short the output to the inverting input.

Evaluation Board Information

The following evaluation boards are available to aid in the testing and layout of this device:

Evaluation Board	Description	Products
KEB002	Single Channel, Dual Supply, 5 and 6-Lead SOT23	FAN4174IS5X
KEB010	Dual Channel, Dual Supply 8-Lead MSOP	FAN4274IMU8X
KEB011	Single Channel, Dual Supply, 5 and 6-Lead SC70	FAN4174IP5X

Evaluation board schematics are shown in Figure 26 and Figure 27; layouts are shown in Figures 28-31.

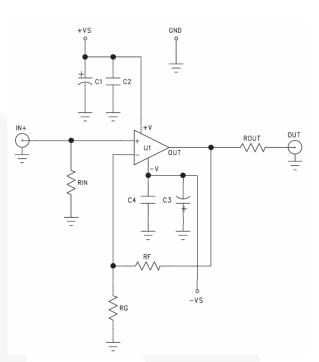


Figure 26. FAN4174 Evaluation Board Schematic (KEV002/KEB011)

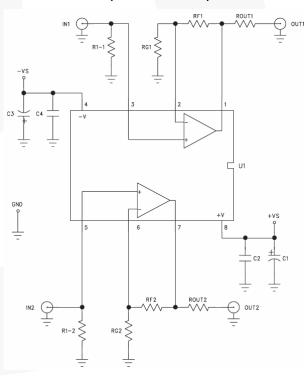
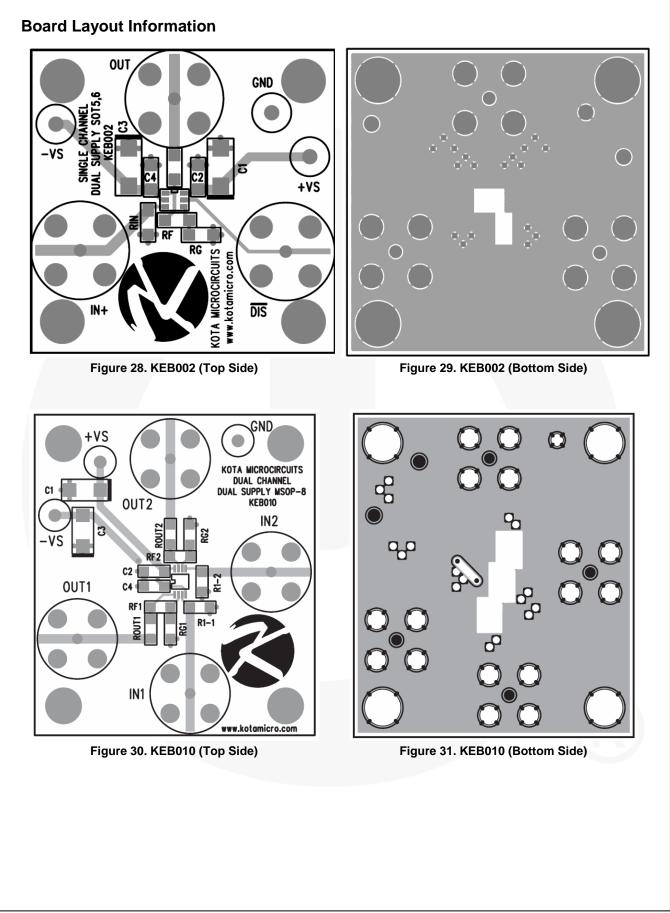


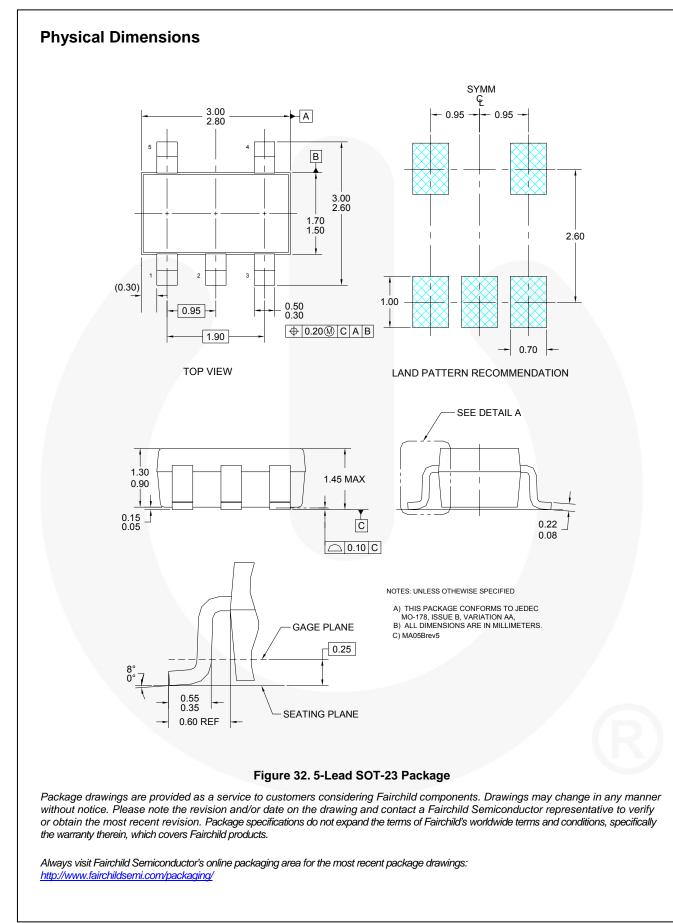
Figure 27. FAN4274 Evaluation Board Schematic (KEB010)

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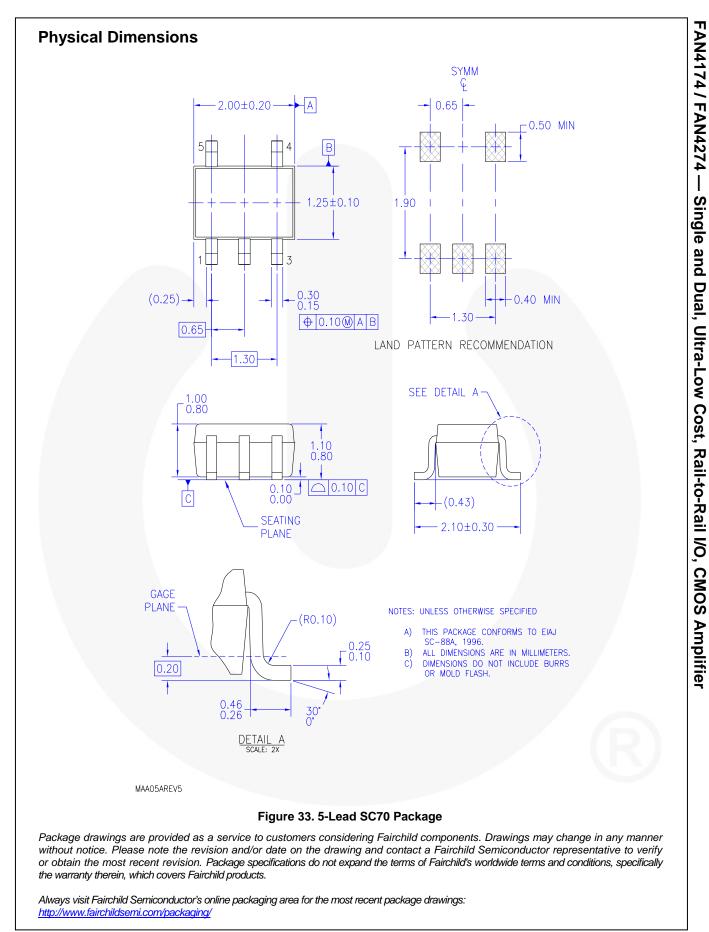
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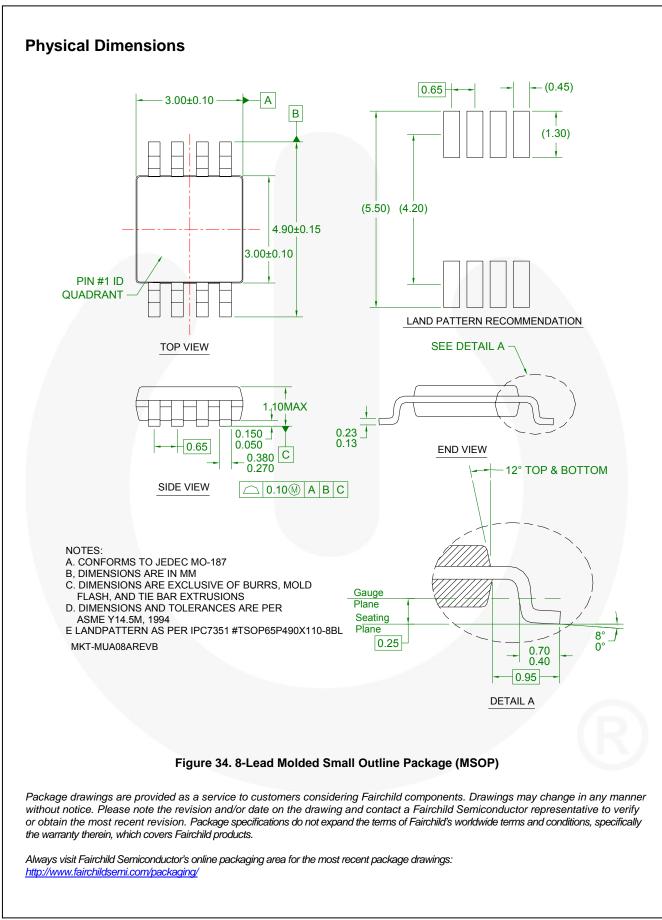
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